

Notice of References Cited	Application/Control No. 10/786,609	Applicant(s)/Patent Under Reexamination NAKANO ET AL.	
	Examiner Jennifer T. Nguyen	Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,919,870	07-2005	Fukuda, Yasuhiro	345/90
*	B	US-6,784,866	08-2004	Udo et al.	345/100
*	C	US-7,006,071	02-2006	Bu, Lin-Kai	345/100
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
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NON-PATENT DOCUMENTS

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	V	
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	X	

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